

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
85V	1.7mΩ@10V	310A



合肥矽普半导体

Siliup Semiconductor Technology Co., Ltd

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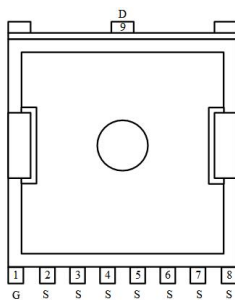
Feature

- Fast Switching
- Low Gate Charge and Rdson
- Advanced Split Gate Trench Technology
- 100% Single Pulse avalanche energy Test

Applications

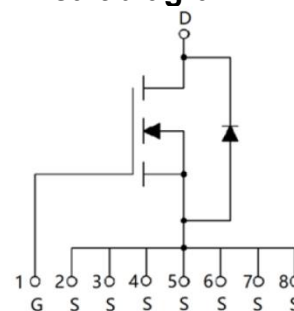
- Power switching application
- DC-DC Converter
- Power Management

Package

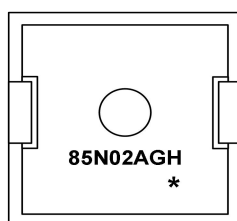


Toll

Circuit diagram



Marking



85N02AGH : Product code
* : Month code

Order Information

Device	Package	Unit/Tape
SP85N02AGHTO	TOLL	2000

Absolute maximum ratings (Ta=25°C unless otherwise noted)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	85	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current1 (Tc=25°C)	I_D	310	A
Continuous Drain Current1 (Tc=100°C)	I_D	207	A
Pulsed Drain Current	I_{DM}	1240	A
Single Pulse Avalanche Energy ¹	E_{AS}	952	mJ
Power Dissipation (Tc=25°C)	P_D	405	W
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	0.35	°C/W
Storage Temperature Range	T_{STG}	-55 to 150	°C
Operating Junction Temperature Range	T_J	-55 to 150	°C

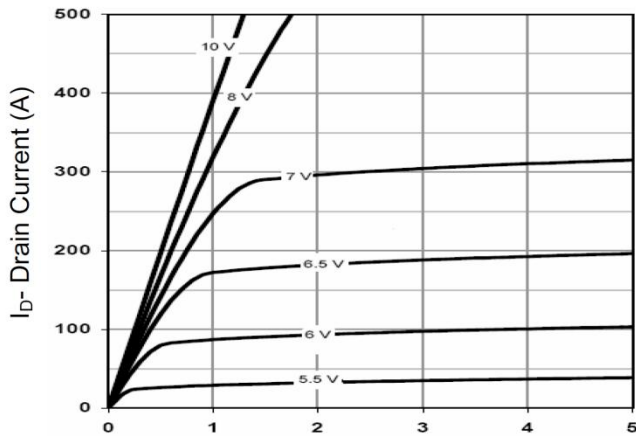
Electrical characteristics (Ta=25°C, unless otherwise noted)

Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$ID = 250\mu A, VGS = 0V$	85	90	-	V
Drain Cut-Off Current	$IDSS$	$VDS = 68V, VGS = 0V$	-	-	1	μA
Gate Leakage Current	$IGSS$	$VGS = \pm 20V, VDS = 0V$	-	-	± 0.1	
Gate Threshold Voltage	$V_{GS(th)}$	$VDS = VGS, ID = 250\mu A$	2.0	3.0	4.0	V
Drain-Source ON Resistance	$R_{DS(ON)}$	$VGS = 10V, ID = 20A$	-	1.7	2.1	m Ω
Dynamic Characteristics						
Input Capacitance	C_{iss}	$VDS = 40V, VGS = 0V, f = 1.0MHz$	-	9860	-	pF
Output Capacitance	C_{oss}		-	1670	-	
Reverse Transfer Capacitance	C_{rss}		-	76	-	
Total Gate Charge	Q_g	$VDS = 40V, VGS = 10V, ID = 165A$	-	143	-	nC
Gate-Source Charge	Q_{gs}		-	51	-	
Gate-Drain Charge	Q_{gd}		-	25	-	
Switching Characteristics						
Turn-On Delay Time	$t_{d(on)}$	$VGS = 10V, VDS = 40V, ID = 165A, RG = 1.6\Omega$	-	27	-	nS
Rise Time	t_r		-	75	-	
Turn-Off Delay Time	$t_{d(off)}$		-	86	-	
Fall Time	t_f		-	35	-	
Drain-Source Body Diode Characteristics						
Source-Drain Diode Forward Voltage	V_{SD}	$IS = 1A, VGS = 0V$	-	-	1.2	V
Maximum Body-Diode Continuous Current	IS		-	-	310	A
Reverse Recovery Time	T_{rr}	$IS = 155A, di/dt = 100A/\mu s, TJ = 25^\circ C$	-	115	-	nS
Reverse Recovery Charge	Q_{rr}		-	320	-	nC

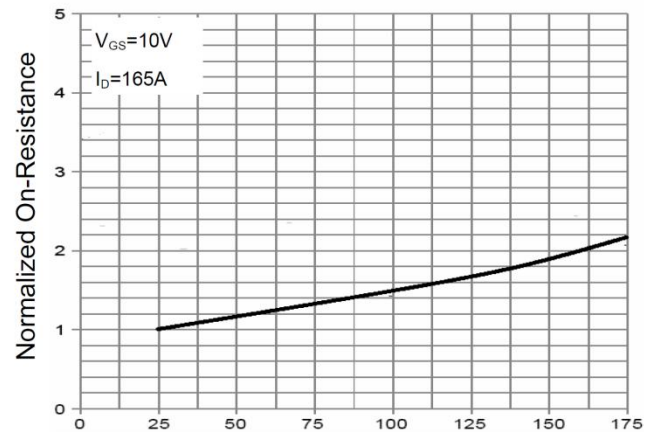
Note :

1. The test condition is VDD=45V, VGS=10V, L=0.1mH, RG=25 Ω

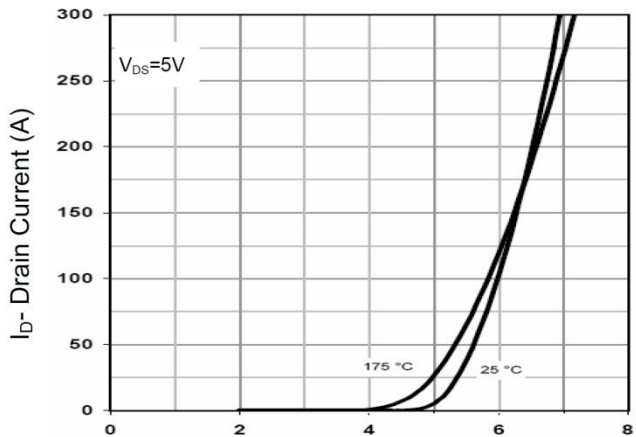
Typical Characteristics



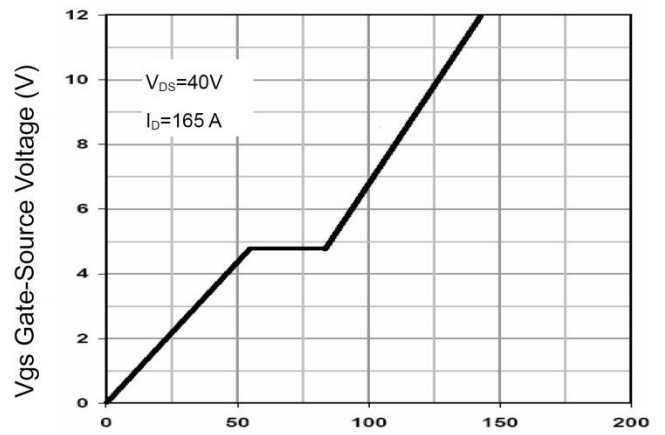
V_{DS} Drain-Source Voltage (V)
Output Characteristics



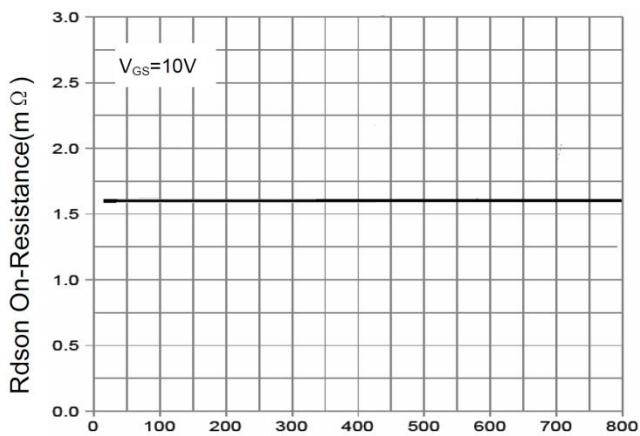
T_J -Junction Temperature(°C)
 $R_{DS(on)}$ -Junction Temperature



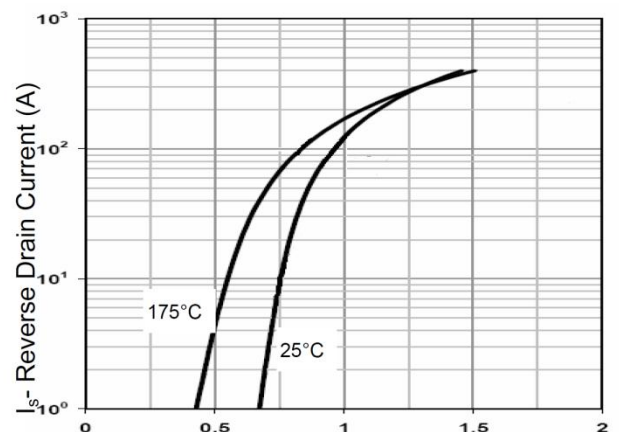
V_{GS} Gate-Source Voltage (V)
Transfer Characteristics



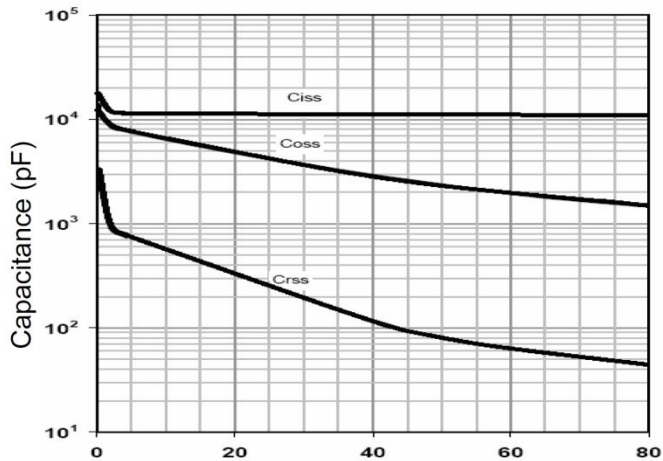
Q_g Gate Charge (nC)
Gate Charge



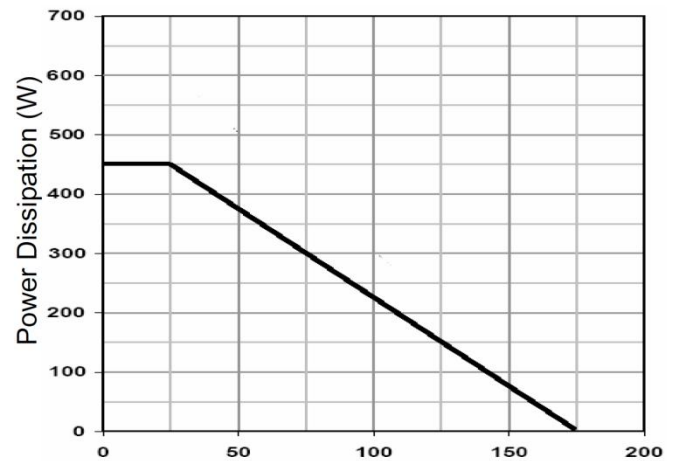
I_D - Drain Current (A)
 $R_{DS(on)}$ - Drain Current



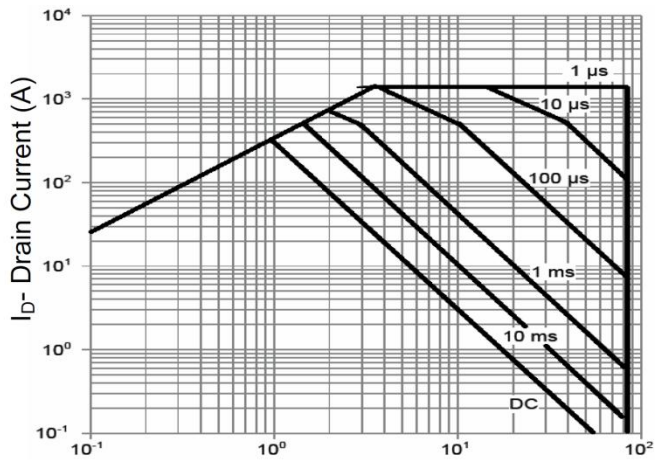
V_{SD} Source-Drain Voltage (V)
Source- Drain Diode Forward



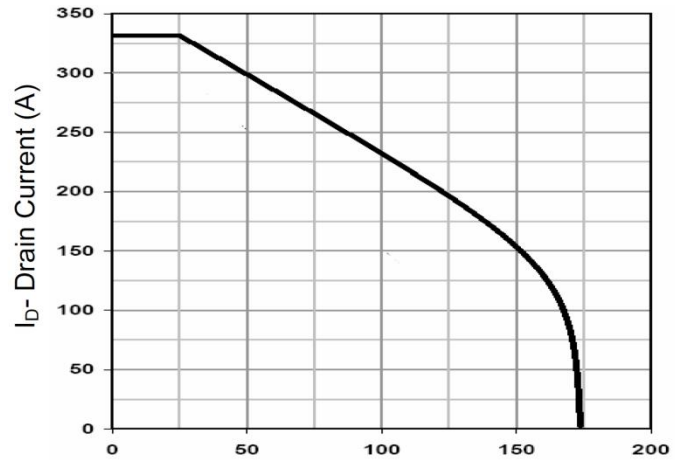
Vds Drain-Source Voltage (V)
Capacitance vs Vds



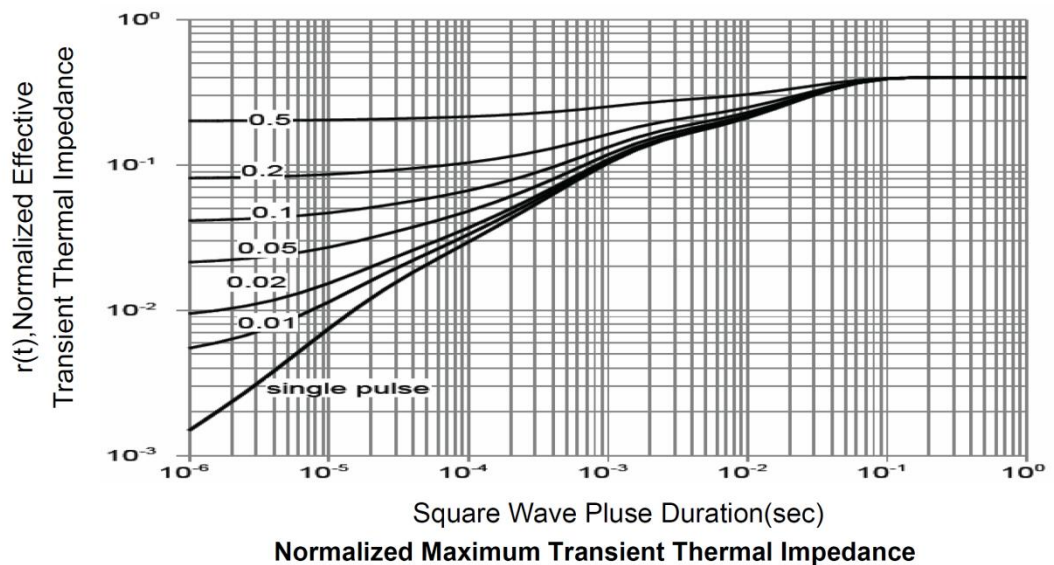
TJ-Junction Temperature(°C)
Power De-rating



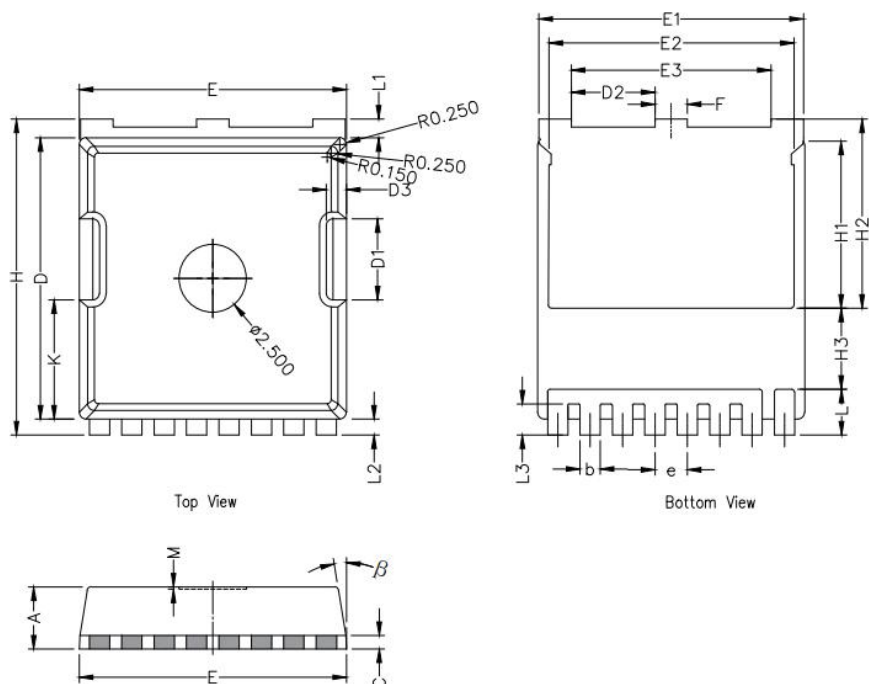
Vds Drain-Source Voltage (V)
Safe Operation Area



TJ-Junction Temperature (°C)
Current De-rating



Normalized Maximum Transient Thermal Impedance

TOLL Package Information


Symbol	Dimensions In Millimeters		
	Min.	Nom.	Max.
A	2.20	2.30	2.40
b	0.65	0.75	0.85
C	0.508 REF		
D	10.25	10.40	10.55
D1	2.85	3.00	3.15
E	9.75	9.90	10.05
E1	9.65	9.80	9.95
E2	8.95	9.10	9.25
E3	7.25	7.40	7.55
e	1.20 BSC		
F	1.05	1.20	1.35
H	11.55	11.70	11.85
H1	6.03	6.18	6.33
H2	6.85	7.00	7.15
H3	3.00 BSC		
L	1.55	1.70	1.85
L1	0.55	0.7	0.85
L2	0.45	0.6	0.75
M	0.08 REF.		
β	8°	10°	12°
K	4.25	4.40	4.55